AN5829S

Sound multiplex decoder IC for the U.S. televisions

■ Overview

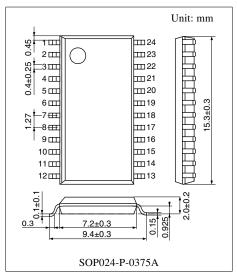
The AN5829S is a multiplex sound demodulation IC dedicated to the U.S. television and incorporates a bidirectional I²C interface (adjustment, mode SW), an AGC circuit and external stereo input switches (2 systems).

■ Features

- Stereo demodulation, SAP demodulation, dbx noise reduction, AGC, external stereo input SW and I²C bus interface are integrated in a single chip
- Bi-directional I²C bus makes it possible to monitor MPX input level, separation adjustment (3 places), mode changeover and receiving status.
- Eliminated external parts (multi-sound block: 21 pieces
 → 14 pieces
- Lower power dissipation ($V_{CC} = 5 \text{ V}, I_{TOT} = 18 \text{ mA}$)

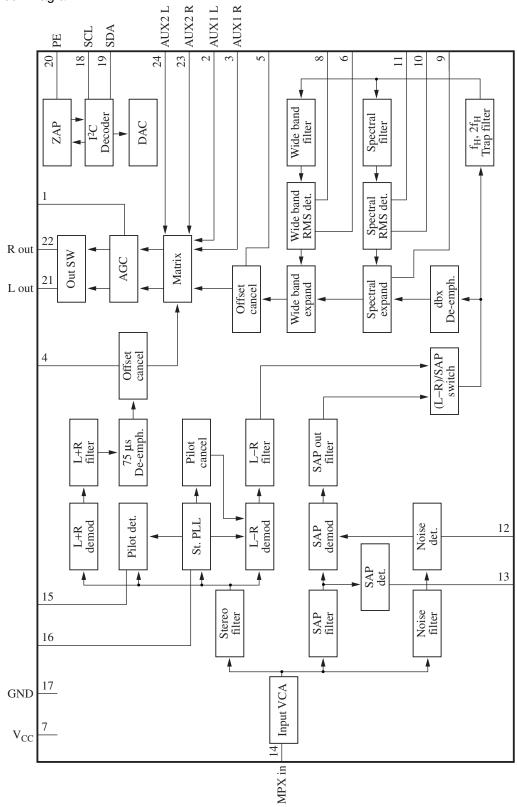
Applications

• Televisions and VCRs for the North American market



Note) The package of this product will be changed to lead-free type (SOP024-P-0375C). See the new package dimensions section later of this datasheet.

■ Block Diagram



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■ Pin Descriptions

Pin No.	Description	Pin No.	Description
1	AGC timing	13	SAP carrier detection
2	External input 1 L-ch	14	Composite input
3	External input 1 R-ch	15	Pilot signal detection
4	75 µs filter offset cancel	16	Stereo PLL filter
5	dbx offset cancel	17	GND
6	Wideband timing	18	SCL
7	$ m V_{CC}$	19	SDA
8	Wideband level sensor input	20	PE for ZAP
9	Spectral filter	21	L-ch output
10	Spectral timing	22	R-ch output
11	Spectral level sensor input	23	External input 2 R-ch.
12	SAP noise level detection	24	External input 2 L-ch.

■ Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit
Supply voltage	V _{CC}	6.0	V
Supply current	I _{CC}	25	mA
Power dissipation *2	P_{D}	150	mW
Operating ambient temperature *1	T _{opr}	-20 to +75	°C
Storage temperature *1	T_{stg}	-55 to +125	°C

Note) The use of this IC, which builds in dbx-TV noise reduction, requires a license agreement with THAT Corporation.

■ Recommended Operating Range

Parameter	Symbol	Range	Unit	
Supply voltage	V _{CC}	4.5 to 5.5	V	

^{*1}: Except fot the operating ambient temperature and storage temperature, all ratings are for $T_a = 25$ °C.

^{*2:} $T_a = 75^{\circ}C$

 \blacksquare Electrical Characteristics at $V_{CC}=5$ V, NR: On, $T_a=25^{\circ}C$

Input level (at 100% modulation) L+R: 75 mV[rms] (pre-emphasis off)

L-R: 150 mV[rms] (dbx noise reduction off)

Pilot: 15 mV[rms]

SAP: 45 mV[rms] (dbx noise reduction off)

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Total circuit current	I _{CC}	No signal	11	18	25	mA
Mono output level	V _{0(MON)}	f = 1 kHz, (mono) 100%mod	430	480	530	mV[rms]
Mono frequency characteristics-1	V _{1(MON)}	f = 300 Hz, (mono) 30%mod	- 0.5	0	0.5	dB
Mono frequency characteristics-2	V _{2(MON)}	f = 8 kHz, (mono) 30%mod	-1.2	- 0.1	0.7	dB
Mono distortion ratio	THD _(MON)	f = 1 kHz, (mono) 100%mod	_	_	0.7	%
Mono noise level	V _{N(MON)}	Input short-circuit, BPF (A curve)	_	_	-60	dBV
(L), (R) output voltage difference	V _{LR(MON)}	f = 1 kHz, (mono) 100%mod	- 0.5	0	0.5	dB
Stereo output level	V _{0(ST)}	f = 1 kHz, (L(R)-only) 100% mod	380	480	580	mV[rms]
Stereo frequency characteristics-1	V _{1(ST)}	f = 300 Hz, (L(R)-only) 30%mod	- 0.7	0	0.7	dB
Stereo frequency characteristics-2	V _{2(ST)}	f = 3 kHz, (L(R)-only) 30% mod	-1	0	1	dB
Stereo frequency characteristics-3	V _{3(ST)}	f = 8 kHz, (L(R)-only) 30% mod	-2.5	- 0.5	1.5	dB
Stereo distortion ratio	THD _(ST)	f = 1 kHz, (L(R)-only) 100% mod	_	_	1	%
Stereo noise level	V _{N(ST)}	f = 15.73 kHz, (f _H), 15 mV[rms] f _H , 2 f _H Trap+BPF	_		-60	dBV
Stereo discrimination level	V _{TH(ST)}	$f = 15.73 \text{ kHz } (f_H)$	4	8	13	mV[rms]
Stereo discrimination hysteresis	V _{HY(ST)}	$f = 15.73 \text{ kHz } (f_H)$	0.5	_	5	dB
SAP output level	V _{0(SAP)}	f = 1 kHz, (SAP) 100%mod	370	500	680	mV[rms]
SAP frequency characteristics-1	V _{1(SAP)}	f = 300 Hz, (SAP) 30%mod	-1	0	1	dB
SAP frequency characteristics-2	V _{2(SAP)}	f = 3 kHz, (SAP) 30%mod	-2.5	- 0.5	1	dB
SAP distortion ratio	THD _(SAP)	f = 1 kHz, (SAP) 100%	_	_	1.5	%
SAP noise level	V _{N(SAP)}	$f = 78.7 \text{ kHz}, (5f_H), V = 45 \text{ mV}[\text{rms}], BPF$	_	_	-70	dBV
SAP discrimination level	V _{TH(SAP)}	$f = 78.7 \text{ kHz}, (5f_{H})$	11	_	26	mV[rms]
SAP discrimination hysteresis	V _{HY(SAP)}	$f = 78.7 \text{ kHz}, (5f_{H})$	0.5	_	5	dB
SAP → Stereo crosstalk	C _{T1}	(SAP)1 kHz, 100%mod (Stereo) pilot-signal	_	_	-50	dB
Stereo → SAP crosstalk	C _{T2}	(Stereo) 1 kHz, 100%mod (SAP) carrier-signal	_	_	-50	dB
SAP → Mono crosstalk	C _{T3}	(SAP) 1 kHz, 100%mod	_	_	-50	dB
Mono → SAP crosstalk	C _{T4}	(Mono) 1 kHz, 100%mod (SAP) carrier-signal		_	-56	dB
AUX 1, AUX 2 to INT crosstalk	C _{T5}	$f = 1 \text{ kHz}, V_{IN} = 500 \text{ mV}[\text{rms}]$	_	_	50	dB
INT, AUX 2 to AUX 1 crosstalk	C _{T6}	INT: (mono) 1 kHz, 100%mod EXT: f = 1 kHz, 500 mV[rms]	_	_	50	dB
INT, AUX 1 to AUX 2 crosstalk	C _{T7}	INT: (mono) 1 kHz, 100%mod EXT: f = 1 kHz, 500 mV[rms]	_	_	50	dB

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\blacksquare Electrical Characteristics at $V_{CC}=5$ V, NR: On, $T_a=25^{\circ}C$ (continued)

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
AGC gain 1*1	V _{AGC1}	$f = 1 \text{ kHz}, V_{IN(EXT)} = 50 \text{ mV[rms]}$	67	100	140	mV[rms]
AGC gain 2 *1	V _{AGC2}	$f = 1 \text{ kHz}, V_{\text{IN(EXT)}} = 500 \text{ mV[rms]}$	180	270	390	mV[rms]
I ² C interface						
Sink current at ACK	I _{ACK}	Maximum pin 2 sink current at ACK	1	2	20	mA
SCL, SDA signal input high level	V _{IHI}		3.5	—	5.0	V
SCL, SDA signal input low level	V _{ILO}	_	0	_	0.9	V
Input available maximum frequency	f_{Imax}		_	_	100	kbit/s

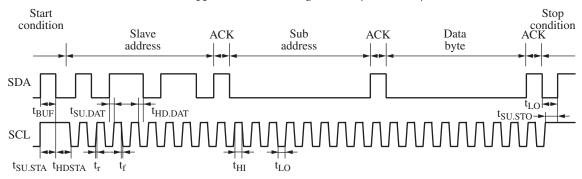
Note) *1: 00H register: D7 = 0, D6 = 1

• Design reference data

Note) The characteristics listed below are theoretical values based on the IC design and are not guaranteed.

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Stereo separation (100%)-1	Sep ₁₀₀₋₁	f = 300 Hz, (L(R)-only) 100% mod	20	35		dB
Stereo separation (100%)-2	Sep ₁₀₀₋₂	f = 1 kHz, (L(R)-only) 100 % mod	17	28	_	dB
Stereo separation (100%)-3	Sep ₁₀₀₋₃	f = 3 kHz, (L(R)-only) 100% mod	20	35	_	dB
Stereo separation (100%)-4	Sep ₁₀₀₋₄	f = 8 kHz, (L(R)-only) 100%mod	10	18	_	dB
Stereo separation (30%)-1	Sep ₃₀₋₁	f = 300 Hz, (L(R)-only) 30%mod	22	35	_	dB
Stereo separation (30%)-2	Sep ₃₀₋₂	f = 1 kHz, (L(R)-only) 30% mod	20	35		dB
Stereo separation (30%)-3	Sep ₃₀₋₃	f = 3 kHz, (L(R)-only) 30% mod	22	35	_	dB
Stereo separation (30%)-4	Sep ₃₀₋₄	f = 8 kHz, (L(R)-only) 30% mod	14	22	_	dB
Stereo separation (10%)-1	Sep ₁₀₋₁	f = 300 Hz, (L(R)-only) 10%mod	20	35	_	dB
Stereo separation (10%)-2	Sep ₁₀₋₂	f = 1 kHz, (L(R)-only) 10% mod	20	35	_	dB
Stereo separation (10%)-3	Sep ₁₀₋₃	f = 3 kHz, (L(R)-only) 10% mod	20	30	_	dB
Stereo separation (10%)-4	Sep ₁₀₋₄	f = 8 kHz, (L(R)-only) 10% mod	14	22		dB
I ² C interface	•		•			
Bus free before start	t _{BUF}	_	4.0	_		μs
Start condition set-up time	t _{SU.STA}	-	4.0	_		μs
Start condition hold time	t _{HD.STA}	_	4.0	_	_	μs
Low period SCL, SDA	t_{LO}	_	4.0	_		μs
High period SCL	t _{HI}	<u>—</u>	4.0	_		μs
Rise time SCL, SDA	t _r	_	_	_	1.0	μs
Fall time SCL, SDA	t _f	_	_	_	0.35	μs
Data set-up time (write)	t _{SU.DAT}	<u>—</u>	0.25	_		μs
Data hold time (write)	t _{HD.DAT}	<u> </u>	0.3	_	_	μs
Acknowledge set-up time	t _{SU.ACK}	_	_	_	3.5	μs
Acknowledge hold time	t _{HD.ACK}	_	0	_	_	μs
Stop condition set-up time	t _{SU.STO}		4.0	_	_	μs

\blacksquare Electrical Characteristics at $V_{CC}=5$ V, NR: On, $T_a=25^{\circ}C$ (continued)



■ Terminal Equivalent Circuits

Pin No.	Equivalent circuit	Description	DC voltage (V)
1	$\begin{array}{c c} V_{cc} \\ \hline \\ 1 \\ \hline \\ 425 \ \Omega \\ \hline \\ 500 \ \Omega \\ \hline \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\ \\$	AGC: AGC level sensor pin	0.5 to 2.0
2	V _{CC} 20.7 kΩ 13.8 kΩ	AUXIL: External input1 L-ch input pin	2.2
3	V_{CC} $20.7 \text{ k}\Omega$ $13.8 \text{ k}\Omega$ 2.2 V GND	AUXIR: External input 1 R-ch input pin	2.2

Pin No.	Equivalent circuit	Description	DC voltage (V)
4	V _{CC} 80 kΩ 80 kΩ 2.2 V GND	OFCAN1: 75 µs filter output Offset cancel pin	2.2
5	V _{CC} 524 Ω 80 kΩ 80 kΩ 2.2 V GND	OFCAN2: dbx output Offset cancel pin	2.2
6	V _{CC} 7.5 μA 15 μA GND	WBTIME: Wide expander effective value detection recovery time set-up pin	2.2
7	<u> </u>	V _{CC} : V _{CC} pin	V _{CC}
8	8 14.4 kΩ	WBDET: RMS detection circuit input pin of wide band expander	2.2

Pin No.	Equivalent circuit	Description	DC voltage (V)
9	V _{CC} 230 Ω 18 kΩ 9 230 Ω 18 kΩ GND	SPEFIL: Variable de-emphasis level adjusting pin	2.2
10	V _{CC} 7.5 μA 15 μA GND	SPETIME: RMS detection recovery time pin of variable de-emphasis	0.2
11	V _{cc} 3.2 kΩ ———————————————————————————————————	SPEDET: RMS detection circuit input pin of variable de-emphasis	2.2
12	V _{CC} V _{CC} 141 kΩ GND	NOISEDET: Noise detecting pin of SAP malfunction-prevention-circuit(Mute SAP demodulation at detecting noise.)	$V_{CC} - 2 V_{BE}$

Pin No.	Equivalent circuit	Description	DC voltage (V)
13	V _{CC} 163 kΩ GND	SAPDET: SAP signal carrier level detection pin	$V_{CC} - 2 V_{BE}$
14	V_{CC} 14 524Ω 7 $2.2 V$ 9 $6ND$	MPXIN: Composite signal input pin	2.2
15	V_{CC} V	PILOTDET: Stereo pilot signal detection pin	$2.2V_{CC} - 2V_{BE}$
16	V _{CC} 58 kΩ GND	PLL: Stereo PLL low pass filter connection pin	$V_{CC} - 2 V_{BE}$
17	_	GND: GND pin	0

Pin No.	Equivalent circuit	Description	DC voltage (V)
18	V _{CC} 51 kΩ GND	SCL: I ² C bus clock input pin	_
19	V_{CC} $1.7 \text{ k}\Omega$ 0 0 0 0 0 0 0 0 0 0	SDA: I ² C bus data input pin	2.2
20	200 GND	PE: Current application input pin for ZAP at final test	
21	21	L-OUT: L-ch. line out output pin	2.2

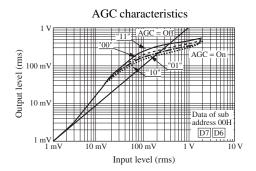
Pin No.	Equivalent circuit	Description	DC voltage (V)
22	V _{CC} 520 Ω 850 Ω 2.2 V GND	R OUT: R-ch. line out output pin	2.2
23	V_{CC} 23 $20.7 \text{ k}\Omega$ $13.8 \text{ k}\Omega$ 72.2 V 6ND	AUX2R: External input 2 L-ch. input pin	2.2
24	V_{CC} 24 $20.7 \text{ k}\Omega$ 7 $13.8 \text{ k}\Omega$ 7 2.2 V 6ND	AUX2L: External input 2 R-ch. input pin	2.2

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■ Usage Notes

1. AGC set-up method

By turning on AGC, the AGC performs 0 dB at a small signal input, Boost at a medium signal and gain reduction at a big signal. It can also control the I/O characteristics of AGC by I²C as shown below:



2. Guarantee of I2C operating temperature

 I^2C bus control operation at an operating ambient temperature is theoretially guranteed based on IC design by means of the inspection using about 50% faster clock speed at the normal temperature ($T_a = 25^{\circ}C$).

Namely it is a theoretical value based on IC design, therefore it is not guranteed at the shipping inspection because the inspection under a high and low temperature is not conducted.

3. Electrostatic breakdown

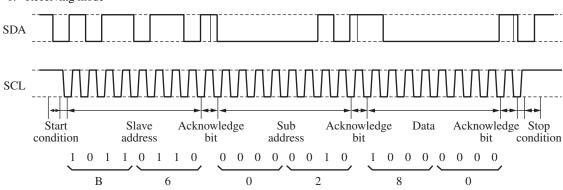
Pay attention to the following levels:

Pin 6: 200 pF, 130 V Pin 10: 200 pF, 150 V Pin 22: 200 pF, 190 V

■ Technical Information

[1] I2C bus

1. Receiving mode



Transmission message

As transfer messages, SCL and SDA are transfered synchronously and serially. SCL is a constant clock frequency and SDA is address data for controlling a receiving side and is sent in parallel by synchronizing with SCL. Data are in principle sent by 8-bit 3-octet (byte) and there exists an acknowledge bit per octet. The frame structure is mentioned below:

1) Start condition

When SDA becomes from high to low at SCL = high, the receiver gets ready to receive.

2) Stop condition

When SDA becomes from low to high at SCL = high, the receiver stops receiving.

3) Slave address

Specified for each device. If any addresses of other devices are sent, receiving will be stopped.

4) Sub-address

Specified for each function.

5) Data

Data for controlling

6) Acknowledge bit

This is the bit that informs the master of data reception every octet. The master sends the high signal and the receiver sends back the low signal as shown with the dotted line in the above figure, thus the master acknowledges reception on the receiver side. If the low signal is not sent back, the reception will be stopped.

Except for the start and stop conditions, SDA does not change at SCL = high.

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■ Technical Information

[1] I2C bus (continued)

1. Receiving mode (continued)

<I2C of this IC>

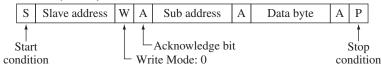
- 1) Enhances adjustment-free mechanism of the TV set thanks to DAC control 3 and 9 switches
- 2) Auto-increment function
 - Sub address 0 *: Auto-increment mode

(Data sequential transfer leads to the sequential change of sub address, so that the data is inputted.)

• Sub address 8 *: Data renewal mode

(With sequential data transfer, data are inputted in the same sub address.)

- 3) I²C bus protocol
 - Slave address
 - Format (normal)



• Auto-increment mode/data renewal mode

S Slave address W A Sub address A Data 1 A Data 2 A / Data n A P											`	\		
	S	Slave address	W	A	Sub address	A	Data 1	A	Data 2	A	_(Data n	Α	P

4) As the initial state of DAC is not guaranteed, never fail to input the following data in a power on mode.

"06" register: "04"

"00" register: adjustment data "01" register: adjustment data

"02" register: "00"

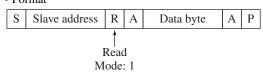
"05" register: adjustment data

2. Transmission mode (read mode)

I²C bus protocol

• Slave address: 10110111 (B7H)

• Format



■ Technical Information (continued)

[1] I²C bus (continued)

• Sub address byte and data byte format

Write mode (slave add.: 10110110)

Sub	Upper MS	В			Lower LSB						
address	D7	D6	D5	D4	D3	D2	D1	D0			
"00"	← AGC	Cadj. —►	•								
"01"	AUXselect 0: AUX1 1: AUX2	AUX SW 0: Off 1: On	•	— High fr	equency sep	paration adju	ıstment —	-			
"02"	$\begin{array}{c} Adj.: 1 \rightarrow On \\ L:VGA \ out \\ R:VCO \ f_H \end{array}$	Mute: 1 → On L: Mute R: Mute	$\begin{array}{c} AGC \\ 1 \rightarrow On \end{array}$	0	FMONO: 1 → On L: L+R R: L+R	0	$\begin{array}{c} St/SAP \\ 0 \rightarrow SAP \end{array}$	(L+R)/SAP $0 \rightarrow SAP$			
"05"	*	*	*	*	Low frequency separation adjustment						
"06"	*	*	*	*	*	*	0	0			

* = Don't care

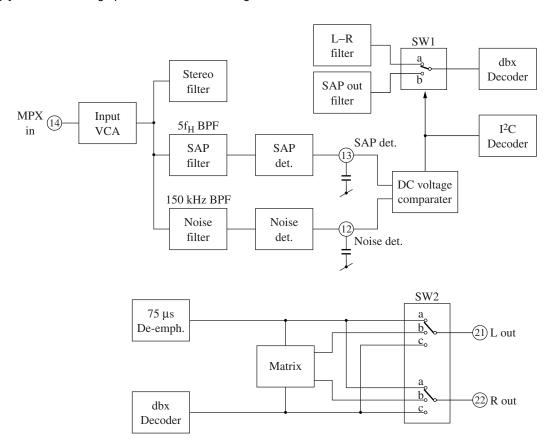
Read mode (slave add.: 10110111)

Upper MS	В		Data	Lower LSB			
D7	D6	D5	D4	D3	D2	D1	D0
Pilot det. $1 \rightarrow DET$	SAP det. $1 \rightarrow DET$	*	*	*	*	*	*

* = Don't care

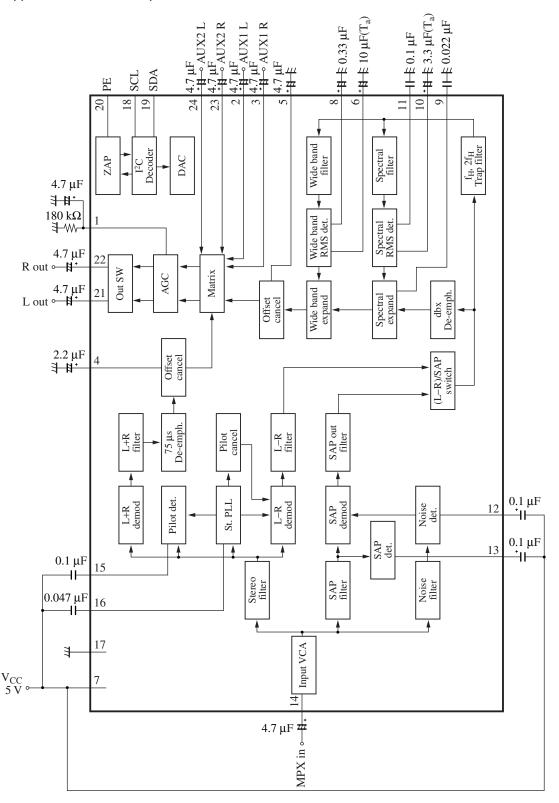
■ Technical Information (continued)

[2] Noise detecting operation in SAP receiving mode

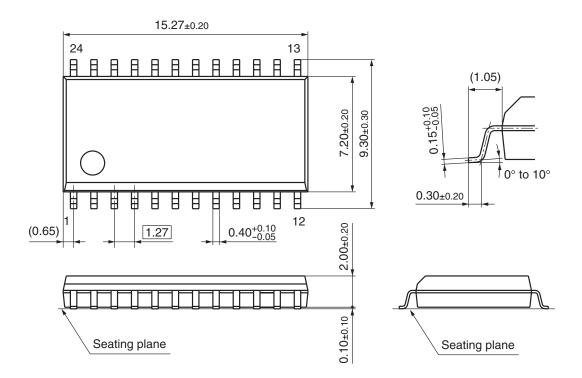


Pin 14 input "02" register		Pin 12, pin 13	SW1	SW2	I ² C SAP det.	Pin 21, pin 22
		DC voltage				
Noise: Small	"00"	$V_{12} > V_{13}$	b	с	3.5 V to 5 V	SAP
Noise: Large	"00"	$V_{12} < V_{13}$	a	a	0 V to 0.9 V	L+R

■ Application Circuit Example



- New Package Dimensions (Unit: mm)
- SOP024-P-0375C (Lead-free package)



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